# DISCRETE SEMICONDUCTORS

# DATA SHEET

# MCR08BT1 Thyristor logic level

**Product specification** 

July 2001





# Thyristor logic level

# MCR08BT1

# **GENERAL DESCRIPTION**

Passivated, sensitive gate thyristor in a plastic envelope, suitable for surface mounting, intended for use in general purpose switching and phase control applications. This device is intended to be interfaced directly to microcontrollers, logic integrated circuits and other low power gate trigger circuits.

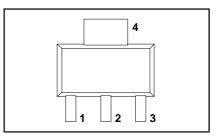
# **QUICK REFERENCE DATA**

SYMBOL	PARAMETER	MAX.	UNIT	
V <sub>DRM</sub> , V <sub>RRM</sub> $I_{T(AV)}$ $I_{T(RMS)}$ $I_{TSM}$	Repetitive peak off-state voltages Average on-state current RMS on-state current Non-repetitive peak on-state current	200 0.5 0.8 9	V A A A	

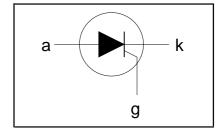
### **PINNING - SOT223**

PIN	DESCRIPTION	
1	cathode	
2	anode	
3	gate	
tab	anode	

# **PIN CONFIGURATION**



### **SYMBOL**



# **LIMITING VALUES**

Limiting values in accordance with the Absolute Maximum System (IEC 134).

SYMBOL	PARAMETER	CONDITIONS	MIN.	MAX.	UNIT
$V_{DRM}, V_{RRM}$	Repetitive peak off-state voltages		-	200 <sup>1</sup>	V
I <sub>T(AV)</sub>	Average on-state current	half sine wave; T <sub>sp</sub> ≤ 112 °C	-	0.5	Α
I <sub>T(RMS)</sub> I <sub>TSM</sub>	RMS on-state current Non-repetitive peak on-state current	all conduction angles half sine wave; T <sub>i</sub> = 25 °C prior to surge	-	0.8	А
		t = 10 ms t = 8.3 ms	- -	8 9	A A
l <sup>2</sup> t	I <sup>2</sup> t for fusing	t = 10 ms	-	0.32	A <sup>2</sup> s
dl <sub>⊤</sub> /dt	Repetitive rate of rise of on-state current after triggering	$I_{TM} = 2 \text{ A}; I_G = 10 \text{ mA}; \\ dI_G/dt = 100 \text{ mA/}\mu\text{s}$	-	50	A/μs
I <sub>GM</sub>	Peak gate current		-	1	Α
$V_{GM}$	Peak gate voltage		-	5	V
$V_{RGM}$	Peak reverse gate voltage		-	5 5 2	l V
P <sub>GM</sub>	Peak gate power	over any 20 ms period	-	_	W W
	Average gate power Storage temperature Operating junction temperature	over any 20 ms period	-40 -	0.1 150 125	Ç

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<sup>1</sup> Although not recommended, off-state voltages up to 800V may be applied without damage, but the thyristor may switch to the on-state. The rate of rise of current should not exceed 15  $A/\mu s$ .

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# THERMAL RESISTANCES

SYMBOL	PARAMETER	CONDITIONS	MIN.	TYP.	MAX.	UNIT
R <sub>th j-sp</sub>	Thermal resistance junction to solder point		-	-	15	K/W
R <sub>th j-a</sub>	Thermal resistance	pcb mounted, minimum footprint pcb mounted; pad area as in fig:14	-	156 70	- -	K/W K/W

# STATIC CHARACTERISTICS

 $T_i = 25$  °C unless otherwise stated

SYMBOL	PARAMETER	CONDITIONS	MIN.	TYP.	MAX.	UNIT
I <sub>GT</sub>	Gate trigger current	$V_D = 12 \text{ V}; I_T = 10 \text{ mA}; \text{ gate open circuit}$	-	50	200	μΑ
I <sub>L</sub>	Latching current	$V_D = 12 \text{ V}; I_{GT} = 0.5 \text{ mA}; R_{GK} = 1 \text{ k}\Omega$	-	2	6	mA
I <sub>I</sub>	Holding current	$V_D = 12 \text{ V}; I_{GT} = 0.5 \text{ mA}; R_{GK} = 1 \text{ k}\Omega$	-	2	5	mA
$V_{\tau}$	On-state voltage	$I_{\tau} = 2 \text{ A}$	-	1.35	1.5	V
V <sub>GT</sub>	Gate trigger voltage	$\dot{V}_D = 12 \text{ V}$ ; $I_T = 10 \text{ mA}$ ; gate open circuit	-	0.5	0.8	V
		$V_{D} = V_{DRM(max)}$ ; $I_{T} = 10 \text{ mA}$ ; $T_{j} = 125 \text{ °C}$ ;	0.2	0.3	-	V
I <sub>D</sub> , I <sub>R</sub>	Off-state leakage current	gate open circuit $V_D = V_{DRM(max)}$ ; $V_R = V_{RRM(max)}$ ; $T_j = 125$ °C; $R_{GK} = 1 \text{ k}\Omega$	-	0.05	0.1	mA

# **DYNAMIC CHARACTERISTICS**

 $T_i = 25$  °C unless otherwise stated

SYMBOL	PARAMETER	CONDITIONS	MIN.	TYP.	MAX.	UNIT
dV <sub>D</sub> /dt	Critical rate of rise of off-state voltage	$V_{DM}$ =67% $V_{DRM(max)}$ ; $T_j$ = 125 °C; exponential waveform; $R_{GK}$ = 1k Ω	-	25	-	V/μs
t <sub>gt</sub>	Gate controlled turn-on time	$I_{TM} = 2 \text{ A}; V_D = V_{DRM(max)}; I_G = 10 \text{ mA}; $ $dI_G/dt = 0.1 \text{ A/us}$	-	2	-	μs
t <sub>q</sub>	Circuit commutated turn-off time	$V_D = 67\% \ V_{DRM(max)}; \ T_i = 125 \ ^{\circ}C; \ I_{TM} = 1.6 \ A; \ V_R = 35 \ V; \ dI_{TM}/dt = 30 \ A/\mu s; \ dV_D/dt = 2 \ V/\mu s; \ R_{GK} = 1 \ k\Omega$	-	100	-	μs

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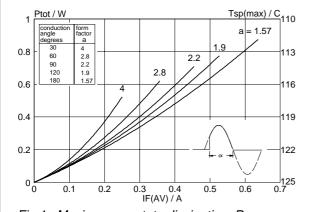


Fig.1. Maximum on-state dissipation,  $P_{tot}$ , versus average on-state current,  $I_{T(AV)}$ , where a = form factor =  $I_{T(RMS)}$ / $I_{T(AV)}$ .

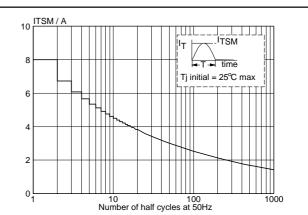


Fig.4. Maximum permissible non-repetitive peak on-state current  $I_{TSM}$ , versus number of cycles, for sinusoidal currents, f = 50 Hz.

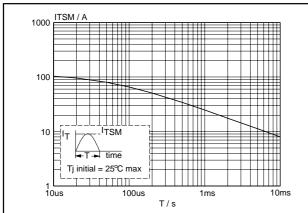


Fig.2. Maximum permissible non-repetitive peak on-state current  $I_{TSM}$ , versus pulse width  $t_p$ , for sinusoidal currents,  $t_p \le 10$ ms.

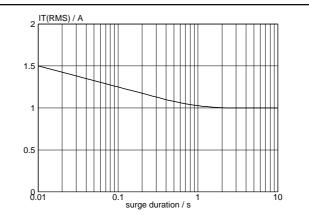


Fig.5. Maximum permissible repetitive rms on-state current  $I_{T(RMS)}$ , versus surge duration, for sinusoidal currents, f = 50 Hz;  $T_{sp} \le 112 ^{\circ}\text{C}$ .

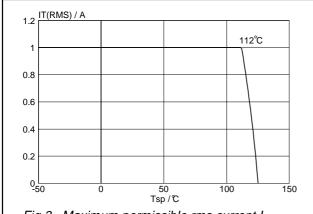
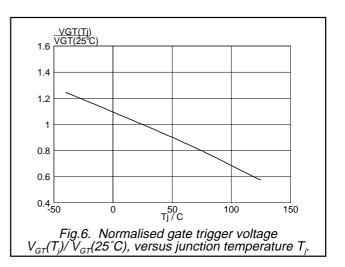


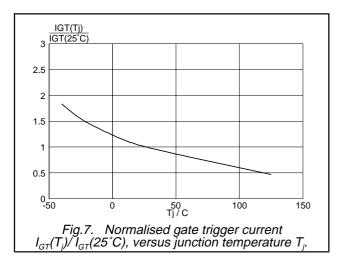
Fig.3. Maximum permissible rms current  $I_{\text{T(RMS)}}$ , versus solder point temperature  $T_{\text{sp}}$ .

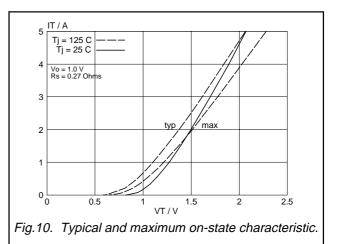


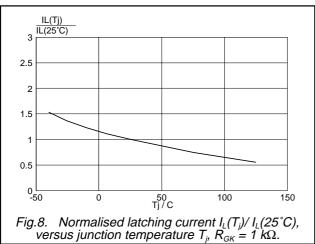
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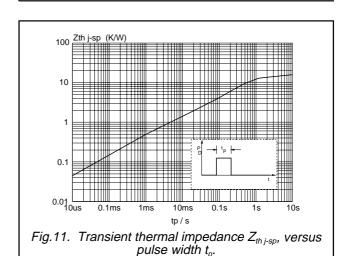
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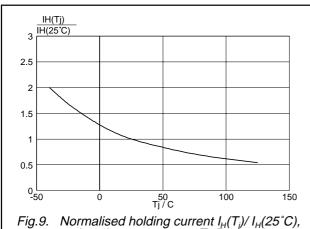
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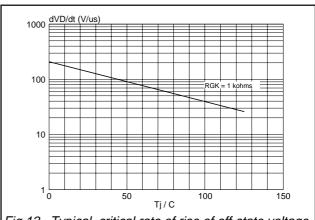


Fig.9. Normalised holding current  $I_H(T_j)/I_H(25^{\circ}C)$ , versus junction temperature  $T_j$ ,  $R_{GK}=1$  k $\Omega$ .

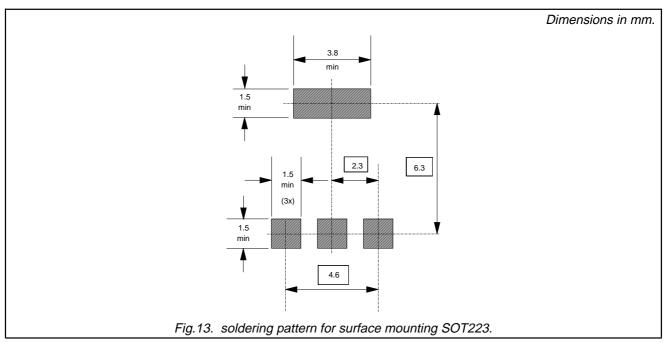
Fig.12. Typical, critical rate of rise of off-state voltage,  $dV_D/dt$  versus junction temperature  $T_{j\cdot}$ 

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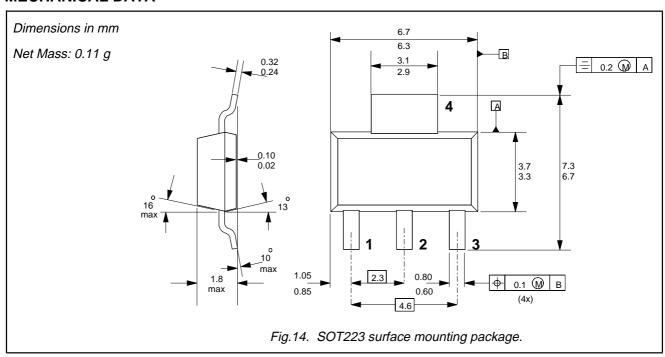
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# **MOUNTING INSTRUCTIONS**



# **MECHANICAL DATA**



# **Notes**

- 1. For further information, refer to Philips publication SC18 " SMD Footprint Design and Soldering Guidelines". Order code: 9397 750 00505. 2. Epoxy meets UL94 V0 at 1/8".

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### **DEFINITIONS**

DATA SHEET STATUS					
DATA SHEET STATUS <sup>2</sup>	PRODUCT STATUS <sup>3</sup>	DEFINITIONS			
Objective data	Development	This data sheet contains data from the objective specification for product development. Philips Semiconductors reserves the right to change the specification in any manner without notice			
Preliminary data	Qualification	This data sheet contains data from the preliminary specification. Supplementary data will be published at a later date. Philips Semiconductors reserves the right to change the specification without notice, in ordere to improve the design and supply the best possible product			
Product data	Production	This data sheet contains data from the product specification. Philips Semiconductors reserves the right to make changes at any time in order to improve the design, manufacturing and supply. Changes will be communicated according to the Customer Product/Process Change Notification (CPCN) procedure SNW-SQ-650A			

### **Limiting values**

Limiting values are given in accordance with the Absolute Maximum Rating System (IEC 134). Stress above one or more of the limiting values may cause permanent damage to the device. These are stress ratings only and operation of the device at these or at any other conditions above those given in the Characteristics sections of this specification is not implied. Exposure to limiting values for extended periods may affect device reliability.

### Application information

Where application information is given, it is advisory and does not form part of the specification.

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<sup>2</sup> Please consult the most recently issued datasheet before initiating or completing a design.

**<sup>3</sup>** The product status of the device(s) described in this datasheet may have changed since this datasheet was published. The latest information is available on the Internet at URL http://www.semiconductors.philips.com.

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Printed in The Netherlands

XXXXXX/700/02/pp8

Date of release: July 2001

Document order number: 9397 750 08943

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